#### 3.3V/2.5V LVCMOS 1:12 Clock Fanout Buffer

#### **Features**

- 12 LVCMOS compatible clock outputs
- Selectable LVCMOS and differential LVPECL compatible clock inputs
- Maximum clock frequency of 350MHz
- Maximum clock skew of 150pS
- Synchronous output stop in logic low state eliminates output runt pulses
- High-impedance output control
- 3.3V or 2.5V power supply
- Drives up to 24 series terminated clock lines
- Ambient temperature range –40°C to +85°C
- 32-Lead LQFP & TQFP packaging
- Supports clock distribution in networking, telecommunication and computing applications
- Pin and Function compatible to MPC9448 and MPC948

#### **Functional Description**

The ASM2I99448 is a 3.3V or 2.5V compatible, 1:12 clock fanout buffer targeted for high performance clock tree applications. With output frequencies up to 350 MHz and output skews less than 150 pS, the device meets the needs of most demanding clock applications.

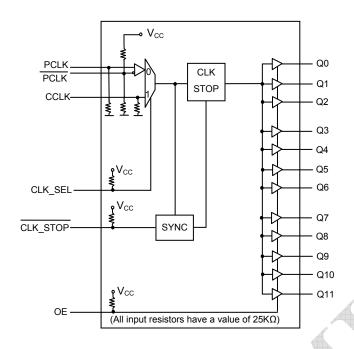
The ASM2I99448 is specifically designed to distribute LVCMOS compatible clock signals up to a frequency of 350MHz. Each output provides a precise copy of the input signal with a near zero skew. The outputs buffers support driving of  $50\Omega$  terminated transmission lines on the incident edge: each output is capable of driving either one parallel terminated or two series terminated transmission lines.

Two selectable, independent clock inputs are available, providing support of LVCMOS and differential LVPECL clock distribution systems. The ASM2I99448 CLK\_STOP control is synchronous to the falling edge of the input clock. It allows the start and stop of the output clock signal only in a logic low state, thus eliminating potential output runt pulses. Applying the OE control will force the outputs into high–impedance mode.

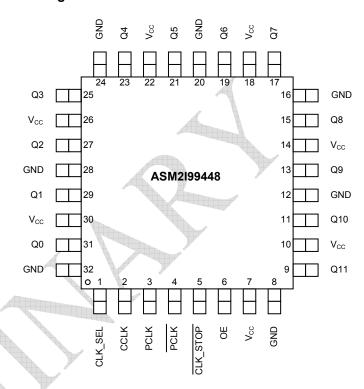
All inputs have an internal pull—up or pull—down resistor preventing unused and open inputs from floating. The device supports a 2.5V or 3.3V power supply and an ambient temperature range of -40°C to +85°C. The ASM2I99448 is pin and function compatible but performance—enhanced to the MPC948.

## rev 0.3

## **Block Diagram**



## Pin Diagram



**Table 1. FUNCTION TABLE** 

Control	Default	0	1
CLK_SEL	1	PECL differential input selected	CCLK input selected
OE	1	Outputs disabled (high-impedance state) <sup>1</sup>	Outputs enabled
CLK_STOP	1	Outputs synchronously stopped in logic low state	Outputs active

Note: 1. OE=0 will high-impedance tristate all outputs independent on CLK\_STOP.

## **Table 2. PIN CONFIGURATION**

Pin#	Pin Name	I/O	Туре	Function
4,3	PCLK, PCLK	Input	LVPECL	LVPECL Clock Inputs
2	CCLK	Input	LVCMOS	Alternative clock signal input
1	CLK_SEL	Input	LVCMOS	Clock input select
5	CLK_STOP	Input	LVCMOS	Clock output enable/disable
6	OE	Input	LVCMOS	Output enable/disable (high–impedance tristate)
31,29,27,25,23,21,19,17,15,13,11,9	Q0 – Q11	Output	LVCMOS	Clock output
8,12,16,20,24,28,32	GND	Supply	Ground	Negative power supply (GND) for I/O and core.
7,10,14,18,22,26,30	Vcc	Supply	V <sub>CC</sub>	Positive power supply for I/O and core. All V <sub>CC</sub> pins must be connected to the positive power supply for correct operation

## Table 3. ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

Symbol	Parameter	Min	Max	Unit
Vcc	Supply Voltage	-0.3	3.9	V
V <sub>IN</sub>	DC Input Voltage	-0.3	V <sub>CC</sub> + 0.3	V
$V_{OUT}$	DC Output Voltage	-0.3	V <sub>CC</sub> + 0.3	V
I <sub>IN</sub>	DC Input Current		±20	mA
I <sub>OUT</sub>	DC Output Current		±50	mA
T <sub>Stor</sub>	Storage Temperature Range	<b>–</b> 65	125	°C

Note: 1. These are stress ratings only and are not implied for functional use. Exposure to absolute maximum ratings for prolonged periods of time may affect device reliability.

#### **Table 4. GENERAL SPECIFICATIONS**

Symbol	Characteristic	Min	Тур	Max	Unit	Condition
V <sub>TT</sub>	Output Termination Voltage		V <sub>CC</sub> ÷2		V	
MM	ESD Protection (Machine Model)	200			V	
НВМ	ESD Protection (Human Body Model)	2000			V	
LU	Latch-up Immunity	200			mA	
C <sub>PD</sub>	Power Dissipation Capacitance		10		pF	Per Output
C <sub>IN</sub>	Input Capacitance		4.0		pF	Inputs

**Table 5. DC CHARACTERISTICS** ( $V_{CC} = 3.3V \pm 5\%$ ,  $T_A = -40^{\circ}C$  to  $+85^{\circ}C$ )

Symbol	Characteristic		Min	Тур	Max	Unit	Condition
V <sub>IH</sub>	Input HIGH Voltage		2.0	A	V <sub>CC</sub> + 0.3	V	LVCMOS
V <sub>IL</sub>	Input LOW Voltage		-0.3	dim	0.8	V	LVCMOS
$V_{PP}$	Peak-to-Peak Input Voltage	PCLK	250			mV	LVPECL
V <sub>CMR</sub> <sup>1</sup>	Common Mode Range	PCLK	1.1		$V_{CC} - 0.6$	V	LVPECL
II <sub>N</sub>	Input Current <sup>2</sup>		4		300	μΑ	$V_{IN} = V_{CC}$ or GND
V <sub>OH</sub>	Output HIGH Voltage		2.4			V	$I_{OH} = -24 \text{mA}^3$
V <sub>OL</sub>	Output LOW Voltage	4			0.55 0.30	V V	$I_{OL} = 24\text{mA}^3$ $I_{OL} = 12\text{mA}$
Z <sub>OUT</sub>	Output Impedance			17		Ω	
I <sub>CCQ</sub> <sup>4</sup>	Maximum Quiescent Supply Cu	rrent			2.0	mA	All V <sub>CC</sub> Pins

Note: 1.  $V_{CMR}$  (DC) is the crosspoint of the differential input signal. Functional operation is obtained when the crosspoint is within the  $V_{CMR}$  range and the input swing lies within the  $V_{PP}$  (DC) specification.

<sup>2.</sup> Input pull-up / pull-down resistors influence input current.

<sup>3.</sup> The ASM2I99448 is capable of driving  $50\Omega$  transmission lines on the incident edge. Each output drives one  $50\Omega$  parallel terminated transmission line to a termination voltage of  $V_{TT}$ . Alternatively, the device drives up to two  $50\Omega$  series terminated transmission lines (for  $V_{CC}$ =3.3V) or one  $50\Omega$  series terminated transmission line (for  $V_{CC}$ =2.5V).

<sup>4.</sup> I<sub>CCQ</sub> is the DC current consumption of the device with all outputs open and the input in its default state or open.



rev 0.3 Table 6. AC CHARACTERISTICS  $(V_{CC} = 3.3V \pm 5\%, T_A = -40^{\circ}C \text{ to } +85^{\circ}C)^{1}$ 

Symbol	Characte	Min	Тур	Max	Unit	Condition	
$f_{ref}$	Input Frequency		0		350	MHz	
$f_{MAX}$	Maximum Output Frequency		0		350	MHz	
$V_{PP}$	Peak-to-peak input voltage	PCLK	400		1000	mV	LVPECL
V <sub>CMR</sub> <sup>2</sup>	Common Mode Range	PCLK	1.3		V <sub>CC</sub> -0.8	V	LVPECL
t <sub>P, REF</sub>	Reference Input Pulse Width		1.4			nS	
$t_r$ , $t_f$	CCLK Input Rise/Fall Time				1.0 <sup>3</sup>	nS	0.8 to 2.0V
t <sub>PLH/HL</sub> t <sub>PLH/HL</sub>	Propagation delay	PCLK to any Q CCLK to any Q	1.6 1.3		3.6 3.3	nS nS	
t <sub>PLZ, HZ</sub>	Output Disable Time				11	nS	
t <sub>PZL, LZ</sub>	Output Enable Time				11	nS	The state of the s
t <sub>s</sub>	Setup time	CCLK to CLK_STOP	0.0			nS	
		PCLK to CLK STOP	0.0	M		nS	
t <sub>H</sub>	Hold time	CCLK to CLK_STOP	1.0			nS	
		PCLK to CLK_STOP	1.5			nS	
t <sub>sk(O)</sub>	Output-to-output Skew				150	pS	
t <sub>sk(PP)</sub>	Device-to-device Skew	PCLK or CCLK to any Q			2.0	nS	
t <sub>SK(P)</sub>	Output pulse skew <sup>4</sup>	Using CCLK Using PCLK	7	P	300 400	pS pS	
DCQ	Output Duty Cycle	f <sub>Q</sub> <170 MHz	45	50	55	%	DC <sub>REF</sub> = 50%
$t_r$ , $t_f$	Output Rise/Fall Time		0.1		1.0	nS	0.55 to 2.4V

- Note: 1. AC characteristics apply for parallel output termination of 50Ω to V<sub>T</sub>.

  2. V<sub>CMR</sub> (AC) is the crosspoint of the differential input signal. Normal AC operation is obtained when the crosspoint is within the V<sub>CMR</sub> range and the input swing lies within the  $V_{PP}$  (AC) specification. Violation of  $V_{CMR}$  or  $V_{PP}$  impacts  $t_{PLH/HL}$  and  $t_{SK(PP)}$ .
  - 3. Violation of the 1.0 nS maximum input rise and fall time limit will affect the device propagation delay, device-to-device skew, reference input pulse width, output duty cycle and maximum frequency specifications.
  - 4. Output pulse skew is the absolute difference of the propagation delay times: | t<sub>pLH</sub> t<sub>pHL</sub> |.

Table 7. DC CHARACTERISTICS ( $V_{CC} = 2.5V \pm 5\%$ ,  $T_A = -40$ °C to +85°C)

Symbol	Characteristics		Min	Тур	Max	Unit	Condition
V <sub>IH</sub>	Input high voltage		1.7		V <sub>CC</sub> + 0.3	V	LVCMOS
$V_{IL}$	Input low voltage	*	-0.3		0.7	V	LVCMOS
$V_{PP}$	Peak-to-peak input voltage	PCLK	250			mV	LVPECL
V <sub>CMR</sub> <sup>1</sup>	Common Mode Range	PCLK	1.0		V <sub>CC</sub> -0.7	V	LVPECL
I <sub>IN</sub>	Input current <sup>2</sup>				300	μA	V <sub>IN</sub> =GND or V <sub>IN</sub> =VCC
Voh	Output High Voltage		1.8			V	$I_{OH}$ = -15 mA <sup>3</sup>
V <sub>OL</sub>	V <sub>OL</sub> Output Low Voltage				0.6	V	$I_{OL}$ = 15 mA <sup>3</sup>
Z <sub>OUT</sub>				19		Ω	
I <sub>CCQ</sub> <sup>4</sup>	Maximum Quiescent Supply	Current			2.0	mA	All V <sub>CC</sub> Pins

Note: 1.  $V_{CMR}$  ( $D\overline{C}$ ) is the crosspoint of the differential input signal. Functional operation is obtained when the crosspoint is within the  $V_{CMR}$ range and the input swing lies within the  $V_{\text{PP}}$  (DC) specification.

<sup>2.</sup> Input pull-up / pull-down resistors influence input current.

The ASM/2199448 is capable of driving 50Ω transmission lines on the incident edge. Each output drives one 50Ω parallel terminated transmission line to a termination voltage of V<sub>TT</sub>. Alternatively, the device drives one 50Ω series terminated transmission lines at V<sub>CC</sub>=2.5V.

<sup>4.</sup> I<sub>CCQ</sub> is the DC current consumption of the device with all outputs open and the input in its default state or open.

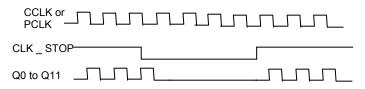


rev 0.3 Table 8. AC CHARACTERISTICS  $(V_{CC} = 2.5V \pm 5\%, T_A = -40^{\circ}C \text{ to } +85^{\circ}C)^{1}$ 

Symbol	Charac	Min	Тур	Max	Unit	Condition	
$f_{ref}$	Input Frequency	0		350	MHz		
$f_{MAX}$	Maximum Output Frequency		0		350	MHz	
$V_{PP}$	Peak-to-peak input voltage	PCLK	400		1000	mV	LVPECL
V <sub>CMR</sub> <sup>2</sup>	Common Mode Range	PCLK	1.2		V <sub>CC</sub> -0.8	V	LVPECL
t <sub>P, REF</sub>	Reference Input Pulse Width		1.4			nS	
$t_r$ , $t_f$	CCLK Input Rise/Fall Time				1.0 <sup>3</sup>	nS	0.8 to 2.0V
t <sub>PLH/HL</sub>	Propagation delay	PCLK to any Q CCLK to any Q	1.5 1.7		4.2 4.4	nS nS	
t <sub>PLZ, HZ</sub>	Output Disable Time				11	nS	
t <sub>PZL, LZ</sub>	Output Enable Time			P	11	nS	
ts	Setup time	CCLK to CLK_STOP	0.0		X	nS	
		PCLK to CLK_STOP	0.0			nS	
t <sub>H</sub>	Hold time	CCLK to CLK_STOP	1.0			nS	
		PCLK to CLK_STOP	1.5		7	nS	
t <sub>sk(O)</sub>	Output-to-output Skew				150	pS	
$t_{\text{sk}(PP)}$	Device-to-device Skew	PCLK or CCLK to any Q			2.7	nS	
t <sub>SK(p)</sub>	Output pulse skew <sup>4</sup>	Using CCLK Using PCLK			200 300	pS pS	
DCQ	Output Duty Cycle	$f_{\rm Q}{<}~350$ MHz and using CLK $f_{\rm Q}{<}200$ MHz and using PCLK	45 45	50 50	55 55	% %	DC <sub>REF</sub> = 50%
$t_r$ , $t_f$	Output Rise/Fall Time		0.1		1.0	nS	0.6 to 1.8V

<sup>Vome (AC) is the crosspoint of the differential input signal. Normal AC operation is obtained when the crosspoint is within the V<sub>CMR</sub> range and the input swing lies within the V<sub>PP</sub> (AC) specification. Violation of V<sub>CMR</sub> or V<sub>PP</sub> impacts t<sub>PLH/HL</sub> and t<sub>SK(PP)</sub>.
3. Violation of the 1.0nS maximum input rise and fall time limit will affect the device propagation delay, device-to-device skew, reference input pulse width, output duty cycle and maximum frequency specifications.
4. Output pulse skew is the absolute difference of the propagation delay times: | t<sub>pLH</sub> - t<sub>pHL</sub> |.</sup> 

#### APPLICATIONS INFORMATION



Timing Diagram
Figure 1. Output Clock Stop (CLK\_STOP)

#### **Driving Transmission Lines**

The ASM2I99448 clock driver was designed to drive high speed signals in a terminated transmission line environment. To provide the optimum flexibility to the user, the output drivers were designed to exhibit the lowest impedance possible. With an output impedance of  $17\Omega$  (Vcc=3.3V), the outputs can drive either parallel or series terminated transmission lines. In most high performance clock networks, point–to–point distribution of signals is the method of choice. In a point–to–point scheme, either series terminated or parallel terminated transmission lines can be used. The parallel technique terminates the signal at the end of the line with a  $50\Omega$  resistance to  $V_{\rm CC} \div 2$ .

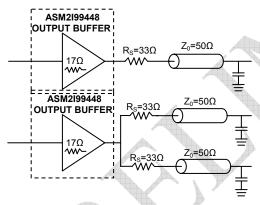


Figure 2. Single versus Dual Transmission
Lines

This technique draws a fairly high level of DC current and thus only a single terminated line can be driven by each output of the ASM2l99448 clock driver. For the series terminated case, however, there is no DC current draw; thus, the outputs can drive multiple series terminated lines. Figure 2 "Single versus Dual Transmission Lines" illustrates an output driving a single series terminated line versus two series terminated lines in parallel. When taken to its extreme, the fanout of the ASM2l99448 clock driver is effectively doubled due to its capability to drive multiple lines at  $V_{\rm CC}{=}3.3 \rm V.$ 

The waveform plots in Figure 3 "Single versus Dual Line Termination Waveforms" show the simulation results of an output driving a single line versus two lines. In both

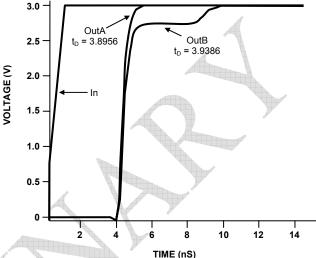


Figure 3 . Single versus Dual Line Termination Waveforms

cases, the drive capability of the ASM2I99448 output buffer is more than sufficient to drive  $50\Omega$  transmission lines on the incident edge. Note from the delay measurements in the simulations a delta of only 43pS exists between the two differently loaded outputs. This suggests that the dual line driving need not be used exclusively to maintain the tight output–to–output skew of the ASM2I99448. The output waveform in Figure 3 "Single versus Dual Line Termination Waveforms" shows a step in the waveform; this step is caused by the impedance mismatch seen looking into the driver. The parallel combination of the  $33\Omega$  series resistor plus the output impedance does not match the parallel combination of the line impedances. The voltage wave launched down the two lines will equal:

$$\begin{aligned} &V_L = V_S \; (\; Z0 \; \div \; (R_S + R_0 \; + Z_0)) \\ &Z_0 = 50 \Omega || \; 50 \Omega \\ &R_S = 33 \Omega || \; 33 \Omega \\ &R_0 = 17 \Omega \\ &V_L = 3.0 \; (\; 25 \; \div \; (16.5 + 17 + 25)) \\ &= 1.28 V \end{aligned}$$

At the load end the voltage will double, due to the near unity reflection coefficient, to 2.5V. It will then increment towards the quiescent 3.0V in steps separated by one round trip delay (in this case 4.0nS).

Since this step is well above the threshold region it will not cause any false clock triggering; however, designers may be uncomfortable with unwanted reflections on the line. To better match the impedances when driving

multiple lines, the situation in Figure 4 "Optimized Dual Line Termination" should be used. In this case, the series terminating resistors are reduced such that when the parallel combination is added to the output buffer impedance the line impedance is perfectly matched.

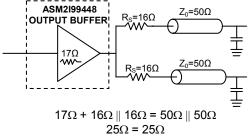


Figure 4. Optimized Dual Line Termination

## Power Consumption of the ASM299448 and Thermal Management

The ASM2I99448 AC specification is guaranteed for the entire operating frequency range up to 350MHz. The ASM2I99448 power consumption and the associated long-term reliability may decrease the maximum frequency limit, depending on operating conditions such as clock frequency, supply voltage, output loading, ambient temperature, vertical convection and thermal conductivity of package and board. This section describes the impact of these parameters on the junction temperature and gives a guideline to estimate the ASM2I99448 die junction temperature and the associated device reliability.

Table 9. Die junction temperature and MTBF

Junction tempera	MTBF (Years)		
100	· ·	20.4	
110	A	9.1	
120	1	4.2	
130	1	2.0	

Increased power consumption will increase the die junction temperature and impact the device reliability (MTBF). According to the system-defined tolerable MTBF, the die junction temperature of the ASM2I99448 needs to be controlled and the thermal impedance of the board/package should be optimized. The power dissipated in the ASM2I99448 is represented in equation 1.

Where ICCQ is the static current consumption of the ASM2I99448, CPD is the power dissipation capacitance per output,  $(M)\Sigma CL$  represents the external capacitive output load, N is the number of active outputs (N is always 12 in case of the ASM2I99448). The ASM2I99448 supports driving transmission lines to maintain high signal integrity and tight timing parameters. Any transmission line will hide the lumped capacitive load at the end of the board trace, therefore,  $\Sigma CL$  is zero for controlled transmission line systems and can be eliminated from equation 1. Using parallel termination output termination results in equation 2 for power dissipation.

In equation 2, P stands for the number of outputs with a parallel or thevenin termination, VOL, IOL, VOH and IOH are a function of the output termination technique and DCQ is the clock signal duty cycle. If transmission lines are used  $\Sigma CL$  is zero in equation 2 and can be eliminated. In general, the use of controlled transmission line techniques eliminates the impact of the lumped capacitive loads at the end lines and greatly reduces the power dissipation of the device. Equation 3 describes the die junction temperature TJ as a function of the power consumption.

Where  $R_{thja}$  is the thermal impedance of the package (junction to ambient) and TA is the ambient temperature. According to Table 9, the junction temperature can be used to estimate the long-term device reliability. Further, combining equation 1 and equation 2 results in a maximum operating frequency for the ASM2I99448 in a series terminated transmission line system, equation 4.

$$\begin{split} P_{TOT} = & \left[ I_{CCQ} + V_{CC} \cdot f_{CLOCK} \cdot \left( N \cdot C_{PD} + \sum_{M} C_{L} \right) \right] \cdot V_{CC} \\ P_{TOT} = & V_{CC} \cdot \left[ I_{CCQ} + V_{CC} \cdot f_{CLOCK} \cdot \left( N \cdot C_{PD} + \sum_{M} C_{L} \right) \right] + \sum_{P} \left[ DC_{Q} \cdot I_{OH} \left( V_{CC} - V_{OH} \right) + \left( 1 - DC_{Q} \right) \cdot I_{OL} \cdot V_{OL} \right] \quad Equation 2 \\ T_{J} = & T_{A} + P_{TOT} \cdot R_{thja} \\ f_{CLOCKMAX} = & \frac{1}{C_{DD} \cdot N \cdot V_{CC}^{2}} \cdot \left[ \frac{T_{JMAX} - T_{A}}{R_{thja}} - \left( I_{CCQ} \cdot V_{CC} \right) \right] \end{split} \quad Equation 4$$

 $T_{\rm J}$ , MAX should be selected according to the MTBF system requirements and Table 9.  $R_{\rm thja}$  can be derived from Table 10. The  $R_{\rm thja}$  represent data based on 1S2P boards, using 2S2P boards will result in lower thermal impedance than indicated below.

Table 10. Thermal package impedance of the 32LQFP

Convection, LFPM	R <sub>thia</sub> (1P2S board), °C/W	R <sub>thia</sub> (2P2S board), °C/W
Still air	86	61
100 lfpm	76	56
200 lfpm	71	54
300 lfpm	68	53
400 lfpm	66	52
500 lfpm	60	49

If the calculated maximum frequency is below 350 MHz, it becomes the upper clock speed limit for the given application conditions. The following eight derating charts describe the safe frequency operation range for the ASM2I99448. The charts were calculated for a maximum tolerable die junction temperature of 110°C (120°C), corresponding to an estimated MTBF of 9.1 years

(4 years), a supply voltage of 3.3V and series terminated transmission line or capacitive loading. Depending on a given set of these operating conditions and the available device convection a decision on the maximum operating frequency can be made.

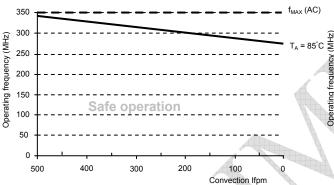


Figure 5. Maximum ASM2I99448 frequency V<sub>cc</sub> = 3.3V, MTBF 9.1 years, driving series terminated transmission lines, 2s2p board

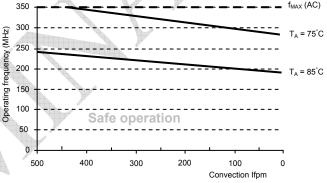


Figure 6. Maximum ASM2I99448 frequency V<sub>CC</sub>= 3.3V, MRBF 9.1 years, 4pF load per line, 2s2p board

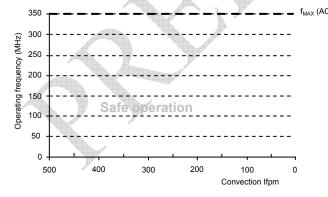


Figure 7. No maximum frequency limitation for V<sub>CC</sub> = 3.3V, MTBF 4 years, driving series terminated transmission lines, 2s2p board

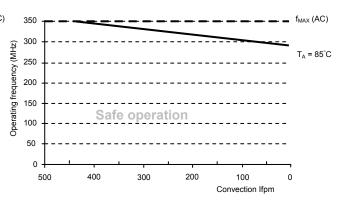


Figure 8. Maximum ASM2I99448 frequency V<sub>CC</sub> = 3.3V, MRBF 4 years, 4pF load per line, 2s2p board

## rev 0.3

The Following Figures illustrate the Measurement Reference for the ASM2I99448 Clock Driver Circuit

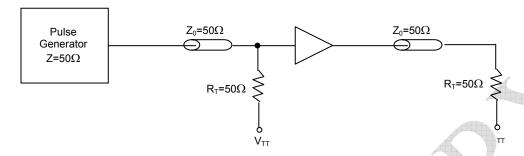


Figure 9. CCLK ASM2I99448 AC Test Reference for  $V_{\text{CC}}$  = 3.3V and  $V_{\text{CC}}$ 

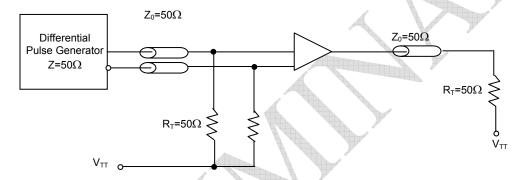


Figure 10. PCLK ASM2I99448 AC Test Reference

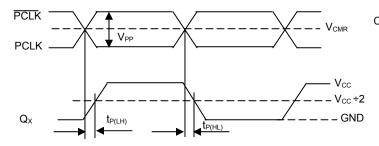


Figure 11. Propagation Delay (t<sub>PD</sub>) Test Reference

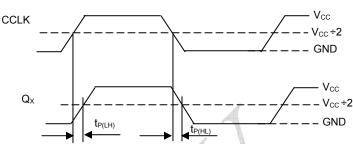
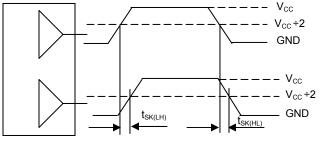


Figure 12. Propagation Delay (t<sub>PD</sub>) Test Reference



The pin-to-pin skew is defined as the worst case difference in propagation between any similar delay path within a single device

Figure 13. Output-to-Output Skew t<sub>SK(LH. HL)</sub>

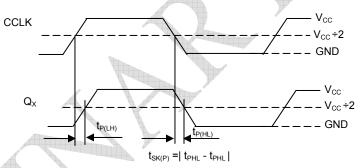
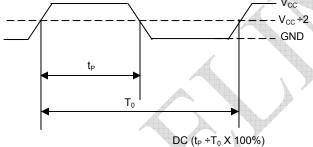
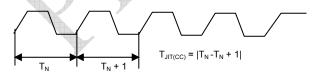


Figure 14. Output Pulse Skew (tsk(P) Test Reference



The time from the output controlled edge to the non-controlled edge, divided by the time output controlled edge, expressed as a percentage.

Figure 15. Output Duty Cycle (DC)



The variation in cycle time of a single between adjacent cycles, over a random sample of adjacent cycle pairs

Figure 17. Cycle-to-Cycle Jitter Reference

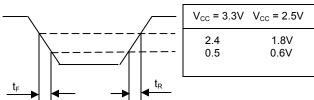


Figure 16. Output Transition Time Test Reference

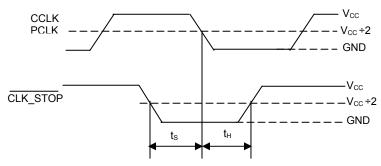
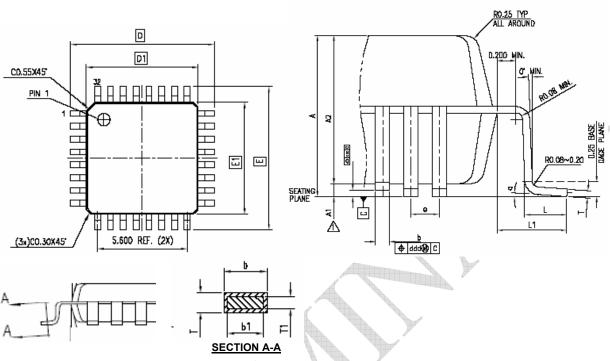


Figure 18. Setup and Hold Time (t<sub>S</sub>, t<sub>H</sub>) Test

# **Package Information**

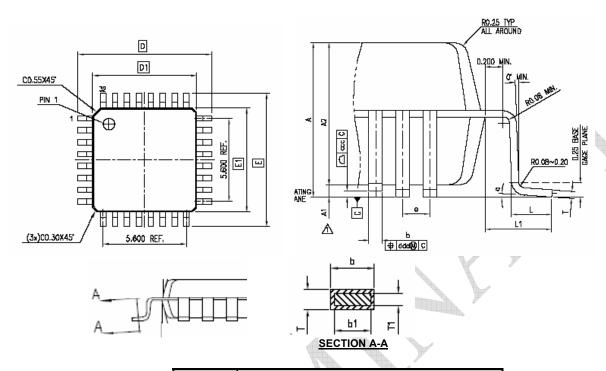
# 32-lead TQFP Package



	Dimensions						
Symbol	Inch	es	Millimeters				
	Min	Max	Min	Max			
A	\\	0.0472		1.2			
A1	0.0020	0.0059	0.05	0.15			
A2	0.0374	0.0413	0.95	1.05			
D	0.3465	0.3622	8.8	9.2			
D1	0.2717	0.2795	6.9	7.1			
E	0.3465	0.3622	8.8	9.2			
E1	0.2717	0.2795	6.9	7.1			
L	0.0177	0.0295	0.45	0.75			
L1	0.03937	7 REF	1.00	REF			
Т	0.0035	0.0079	0.09	0.2			
T1	0.0038	0.0062	0.097	0.157			
b	0.0118	0.0177	0.30	0.45			
b1	0.0118	0.0157	0.30	0.40			
R0	0.0031	0.0079	0.08	0.2			
а	0°	7°	0°	7°			
е	0.031 E	BASE	0.8 B	ASE			

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# 32-lead LQFP Package

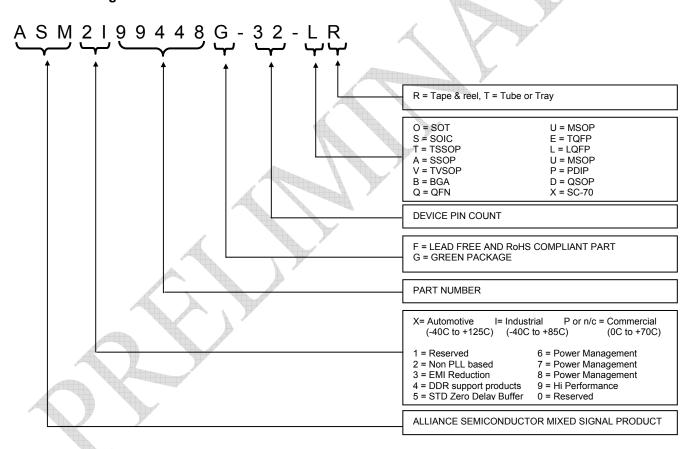


		Dimensions						
Symbol	Inch	es	Millimeters					
	Min	Max	Min	Max				
Α	· · · · · ·	0.0630		1.6				
A1	0.0020	0.0059	0.05	0.15				
A2	0.0531	0.0571	1.35	1.45				
D	0.3465	0.3622	8.8	9.2				
D1	0.2717	0.2795	6.9	7.1				
E	0.3465	0.3622	8.8	9.2				
E1	0.2717	0.2795	6.9	7.1				
L	0.0177	0.0295	0.45	0.75				
L1	0.03937	7 REF	1.00	REF				
Т	0.0035	0.0079	0.09	0.2				
T1	0.0038	0.0062	0.097	0.157				
b	0.0118	0.0177	0.30	0.45				
b1	0.0118	0.0157	0.30	0.40				
R0	0.0031	0.0079	0.08	0.20				
е	0.031 E	BASE	0.8 BASE					
а	0°	7°	0°	7°				

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Ordering Information

Part Number	Marking	Package Type	Operating Range
ASM2I99448-32-LT	ASM2I99448L	32-pin LQFP, Tray	Industrial
ASM2I99448-32-LR	ASM2I99448L	32-pin LQFP –Tape and Reel	Industrial
ASM2I99448G-32-LT	ASM2I99448GL	32-pin LQFP, Tray, Green	Industrial
ASM2I99448G-32-LR	ASM2I99448GL	32-pin LQFP –Tape and Reel, Green	Industrial
ASM2I99448-32-ET	ASM2I99448E	32-pin TQFP, Tray	Industrial
ASM2I99448-32-ER	ASM2I99448E	32-pin TQFP –Tape and Reel	Industrial
ASM2I99448G-32-ET	ASM2I99448GE	32-pin TQFP, Tray, Green	Industrial
ASM2I99448G-32-ER	ASM2I99448GE	32-pin TQFP –Tape and Reel, Green	Industrial

## **Device Ordering Information**



Licensed under US patent #5,488,627, #6,646,463 and #5,631,920.

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Note: This product utilizes US Patent # 6,646,463 Impedance Emulator Patent issued to Alliance Semiconductor, dated 11-11-2003

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